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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Takashi YOKOKAWA et al.
International Application No.: PCT/JP04/005551
International Filing Date: April 19, 2004
For: DECODING METHOD, DECODING APPARATUS,
AND PROGRAM

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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP04/005551. Also enclosed is a copy of Form PTO-1449 and the International Search Report.


REMARKS

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-05080	SERIAL NO. 10/521191 Filed Concurrently Herewith
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LIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	2002/0116677	08/22/02	Morelos-Zaragoza			
	AB	6, 539, 367	03/25/03	Blanksby et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	JP 2004-147318	05/20/04	Japan			
	AM	JP 2002-118474	04/19/02	Japan			
	AN	JP 2002-33670	01/31/02	Japan			
	AO	EP 1 158 682	11/28/01	Europe			
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